

## QUERY CONTROL FORM

**RTIS USE ONLY**

Application No. 09/454,526  
Examiner-GAU Lee 2876

Prepared by A. Augustin  
Date 9/17/04  
No. of queries 1

|                 |          |
|-----------------|----------|
| Tracking Number | 05993540 |
| Week Date       | 8/09/04  |
| IFW             |          |

## JACKET

- a. Serial No.
- b. Applicant(s)
- c. Continuing Data
- d. PCT
- e. Domestic Priority

- f. Foreign Priority
- g. Disclaimer
- h. Microfiche Appendix
- i. Title
- j. Claims Allowed

k. Print Claim(s)  
l. Print Fig.  
m. Searched Column  
n. PTO-270/328  
o. PTO-892

p. PTO-1449  
q. PTOL-85b  
r. Abstract  
s. Sheets/Figs  
t. Other

## SPECIFICATION

- a. Page Missing
- b. Text Continuity
- c. Holes through Data
- d. Other Missing Text
- e. Illegible Text
- f. Duplicate Text
- g. Brief Description
- h. Sequence Listing
- i. Appendix
- j. Amendments
- k. Other

## CLAIMS

- a. Claim(s) Missing
- b. Improper Dependency
- c. Duplicate Numbers
- d. Incorrect Numbering
- e. Index Disagrees
- f. Punctuation
- g. Amendments
- h. Bracketing
- i. Missing Text
- j. Duplicate Text
- k. Other

## MESSAGE

MESSAGE PTO 1449: Please either initial or line through citations. Copy provided for reference.

Thank you!

initials *ASA*

## RESPONSE

initials

|   |   |                                    |                               |
|---|---|------------------------------------|-------------------------------|
| Form PTO-1449   | US Dept. of Commerce<br>PATENT & TRADEMARK OFFICE | ATTY DOCKET NO.<br>07447.0044-0    | APPLICATION NO.<br>09/454,526 |
| INFORMATION DISCLOSURE STATEMENT<br>(Use several sheets if necessary) |   | APPLICANT Matthew G. Gorbet et al. |                               |
|   |   | FILING DATE 12/6/99                | GROUP ART UNIT 2876           |

## U.S. PATENT DOCUMENTS

| EXAMINER<br>INITIAL | DOCUMENT NUMBER | PUBLICATION<br>DATE | NAME OF PATENTEE | CLASS | SUB<br>CLASS |
|---------------------|-----------------|---------------------|------------------|-------|--------------|
|                     |                 |                     |                  |       |              |
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## FOREIGN PATENT DOCUMENTS

|  | COUNTRY | DOCUMENT NUMBER | PUBLICATION<br>DATE | NAME OF PATENTEE OR APPLICANT       | TRANSLATION<br>Y/N |
|--|---------|-----------------|---------------------|-------------------------------------|--------------------|
|  | EP      | 0 254 644 A2    | 1/27/88             | Fairchild Semiconductor Corporation | Y                  |
|  | EP      | 0 923 050 A2    | 6/16/99             | Affymetrix, Inc.                    | Y                  |
|  |         |                 |                     |                                     |                    |
|  |         |                 |                     |                                     |                    |
|  |         |                 |                     |                                     |                    |

## OTHER DOCUMENTS (Including Author (In CAPS), Title, Publication Date, Pages, etc.)

|   |                 |
|---|-----------------|
| EP Search Report for application EP 00 31 0774 (U.S. Counterparts 09/454,526; 09/455,304 and 09/456,105) dated July 18, 2003.   |                 |
|   |                 |
|   |                 |
| EXAMINER  | DATE CONSIDERED |
| Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. |                 |